## Applicant(s)/Patent Under Reexamination Application/Control No. 10/086,510 CHANG ET AL. **Notice of References Cited** Art Unit Examiner Page 1 of 1 Sheridan K Snedden 1653 **U.S. PATENT DOCUMENTS** Document Number Date Classification Name Country Code-Number-Kind Code MM-YYYY 435/69.1 US-5,968,772 10-1999 Matsushiro, Aizo Α US-В US-С US-D Ε US-F US-US-G Н US-US-1 US-J Κ US-US-L US-М FOREIGN PATENT DOCUMENTS Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)

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